


<b>Search Notes</b> 	<b>Application/Control No.</b> 10688935	<b>Applicant(s)/Patent Under Reexamination</b> OMIYA ET AL.
	<b>Examiner</b> NHAN T TRAN	<b>Art Unit</b> 2622

SEARCHED			
Class	Subclass	Date	Examiner
348	240.99, 345	11/7/2007	NT
396	348-350	11/7/2007	NT
348	335	5/16/2008	NT
348	373	11/26/08	NT

SEARCH NOTES		
Search Notes	Date	Examiner
EAST search (USPAT, PGUP, JPO, EPO, DERWENT, IBM_TDB)	11/7/2008	NT
348/362 (text search)	11/8/2007	NT
396/72-75 (text search)	11/8/2007	NT
Text search all classes	11/8/2007	NT
Updated text search in all classes	5/16/2008	NT
Updated text search in all classes	11/26/08	NT
Inventorship search	11/26/08	NT

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
ALL	PGUP text search	11/26/08	NT

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